

BFR380L3

Low profile linear silicon NPN RF bipolar transistor



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Technical documents



Simulation



Support

Product description

The BFR380L3 is a low noise device based on Si that is part of Infineon's established third generation RF bipolar transistor family. Its high transition frequency and low current and low noise characteristics make the device suitable for a broad range of applications as high as 3.5 GHz. It remains cost competitive without compromising on ease of use.



Feature list

- Minimum noise figure $NF_{min} = 1.1$ dB at 1.8 GHz, 3 V, 8 mA
- High gain $G_{ma} = 14$ dB at 1.8 GHz, 3 V, 40 mA
- $OIP_3 = 29.5$ dBm at 1.8 GHz, 3 V, 40 mA

Product validation

Qualified for industrial applications according to the relevant tests of JEDEC47/20/22.

Potential applications

- Low noise amplifiers (LNAs) for DVB-T/H
- LNAs for TV white space application
- Low noise, high linearity amplifiers for sub-1 GHz ISM band applications

Device information

Table 1 Part information

| Product name / Ordering code | Package | Pin configuration | | | Marking | Pieces / Reel |
|-------------------------------|----------|-------------------|-------|-------|---------|---------------|
| BFR380L3 / BFR380L3E6327XTMA1 | TSLP-3-1 | 1 = B | 2 = E | 3 = C | FC | 15000 |

Attention: ESD (Electrostatic discharge) sensitive device, observe handling precautions

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Absolute maximum ratings

1 Absolute maximum ratings

Table 2 Absolute maximum ratings at $T_A = 25\text{ °C}$ (unless otherwise specified)

| Parameter | Symbol | Values | | Unit | Note or test condition |
|---------------------------------------|-----------|--------|------|------|-------------------------|
| | | Min. | Max. | | |
| Collector emitter voltage | V_{CEO} | - | 6 | V | Open base |
| Collector emitter voltage | V_{CES} | | 15 | | E-B short circuited |
| Collector base voltage | V_{CBO} | | 15 | | Open emitter |
| Emitter base voltage | V_{EBO} | | 2 | | Open collector |
| Base current | I_B | | 14 | mA | - |
| Collector current | I_C | | 80 | | |
| Total power dissipation ¹⁾ | P_{tot} | | 380 | mW | $T_S \leq 96\text{ °C}$ |
| Junction temperature | T_J | | 150 | °C | - |
| Storage temperature | T_{Stg} | -55 | | | |

Attention: *Stresses above the max. values listed here may cause permanent damage to the device. Exposure to absolute maximum rating conditions for extended periods may affect device reliability. Exceeding only one of these values may cause irreversible damage to the integrated circuit.*

¹ T_S is the soldering point temperature. T_S is measured on the emitter lead at the soldering point of the PCB.

Thermal characteristics

2 Thermal characteristics

Table 3 Thermal resistance

| Parameter | Symbol | Values | | | Unit | Note or test condition |
|----------------------------|------------|--------|------|------|------|------------------------|
| | | Min. | Typ. | Max. | | |
| Junction - soldering point | R_{thJS} | - | 140 | - | K/W | - |

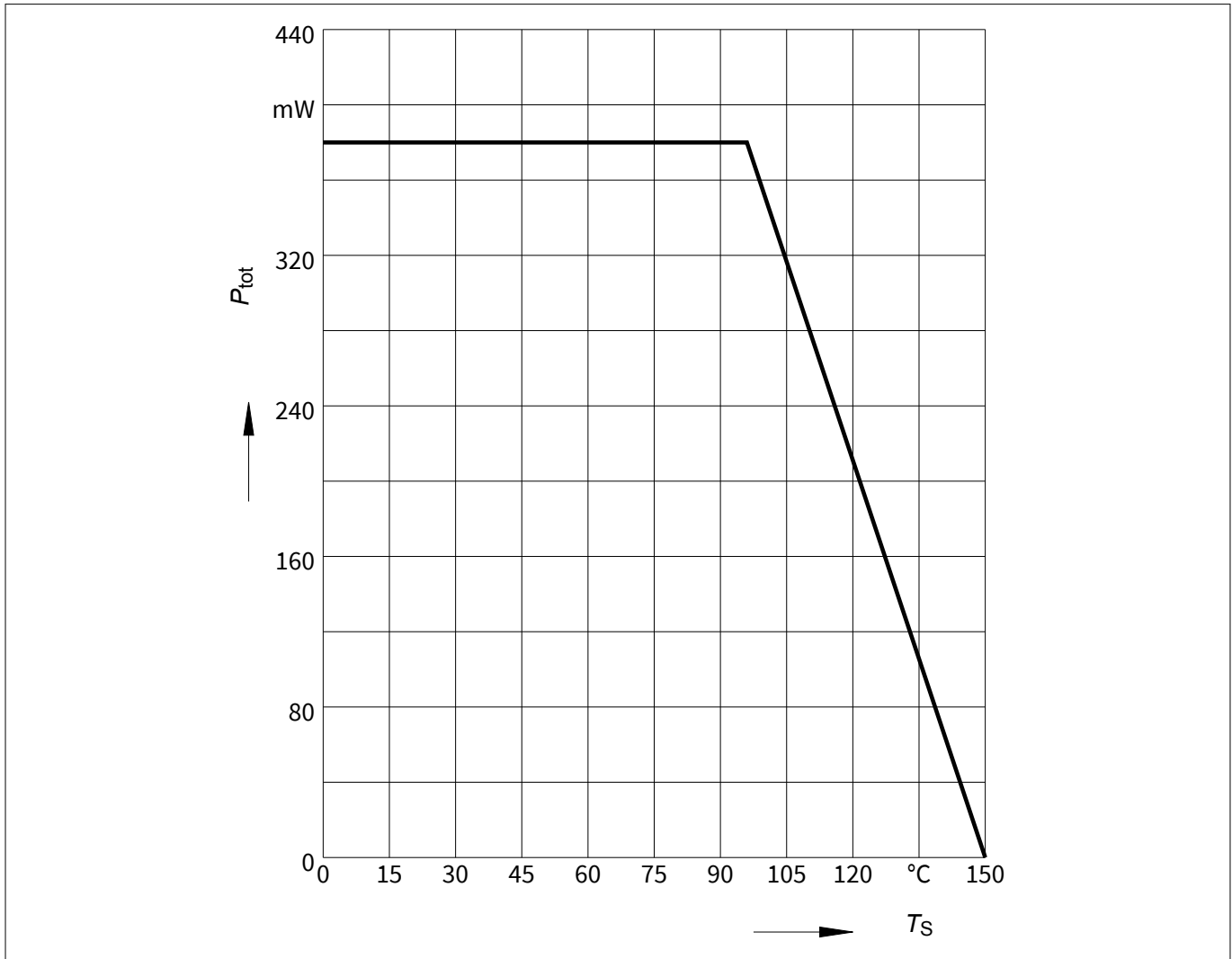


Figure 1 Total power dissipation $P_{tot} = f(T_s)$

Electrical characteristics

3 Electrical characteristics

3.1 DC characteristics

Table 4 DC characteristics at $T_A = 25\text{ °C}$ (unless otherwise specified)

| Parameter | Symbol | Values | | | Unit | Note or test condition |
|-------------------------------------|---------------|--------|------|--------------------|------|---|
| | | Min. | Typ. | Max. | | |
| Collector emitter breakdown voltage | $V_{(BR)CEO}$ | 6 | 9 | – | V | $I_C = 1\text{ mA}$, $I_B = 0$, open base |
| Collector emitter leakage current | I_{CES} | – | 1 | 30 ²⁾ | nA | $V_{CE} = 5\text{ V}$, $V_{BE} = 0$, E-B short circuited |
| | | | – | 1000 ²⁾ | | $V_{CE} = 15\text{ V}$, $V_{BE} = 0$, E-B short circuited |
| Collector base leakage current | I_{CBO} | | | 30 ²⁾ | | $V_{CB} = 5\text{ V}$, $I_E = 0$, open emitter |
| Emitter base leakage current | I_{EBO} | | 10 | 500 ²⁾ | | $V_{EB} = 1\text{ V}$, $I_C = 0$, open collector |
| DC current gain | h_{FE} | 90 | 120 | 160 | | $V_{CE} = 3\text{ V}$, $I_C = 40\text{ mA}$, pulse measured |

3.2 General AC characteristics

Table 5 General AC characteristics at $T_A = 25\text{ °C}$

| Parameter | Symbol | Values | | | Unit | Note or test condition |
|-------------------------------|----------|--------|------|------|------|--|
| | | Min. | Typ. | Max. | | |
| Transition frequency | f_T | 11 | 14 | – | GHz | $V_{CE} = 3\text{ V}$, $I_C = 40\text{ mA}$, $f = 1\text{ GHz}$ |
| Collector base capacitance | C_{CB} | – | 0.45 | 0.8 | pF | $V_{CB} = 5\text{ V}$, $V_{BE} = 0$, $f = 1\text{ MHz}$, emitter grounded |
| Collector emitter capacitance | C_{CE} | | 0.18 | – | | $V_{CE} = 5\text{ V}$, $V_{BE} = 0$, $f = 1\text{ MHz}$, base grounded |
| Emitter base capacitance | C_{EB} | | 1 | | | $V_{EB} = 0.5\text{ V}$, $V_{CB} = 0$, $f = 1\text{ MHz}$, collector grounded |

² Maximum values not limited by the device but by the short cycle time of the 100% test.

Electrical characteristics

3.3 Frequency dependent AC characteristics

Measurement setup is a test fixture with Bias-T's in a 50 Ω system, $T_A = 25\text{ °C}$.

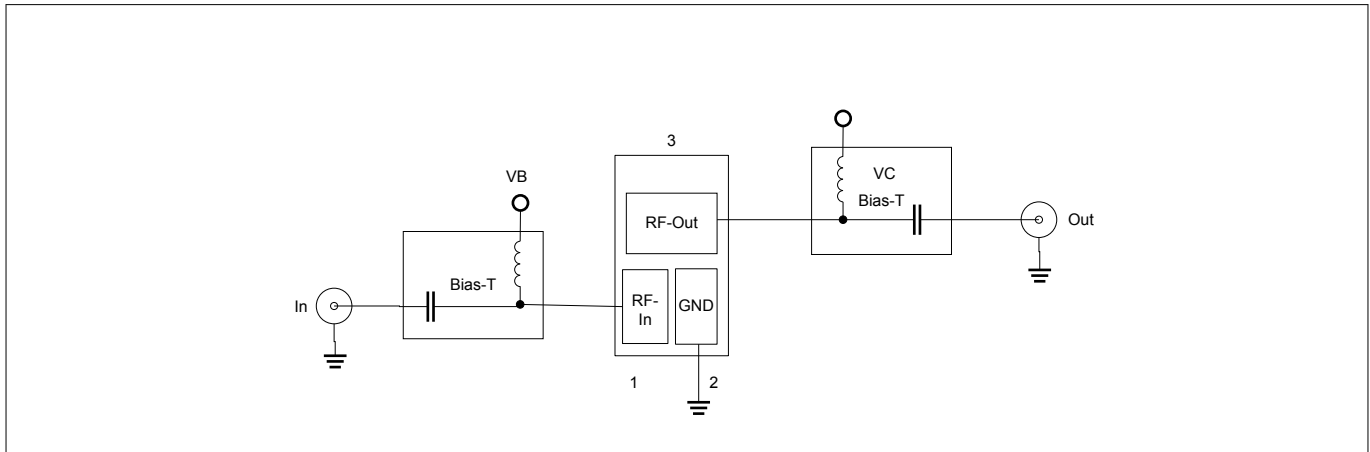


Figure 2 Testing circuit

Table 6 AC characteristics, $V_{CE} = 3\text{ V}$, $f = 1.8\text{ GHz}$

| Parameter | Symbol | Values | | | Unit | Note or test condition |
|---|--------------------------|-------------|------------|--------------|------|---|
| | | Min. | Typ. | Max. | | |
| Power gain | | | | | dB | $I_C = 40\text{ mA}$ |
| <ul style="list-style-type: none"> Maximum power gain Transducer gain | G_{ma} $ S_{21} ^2$ | 11.5 9.5 | 14 11.5 | 16.5 13.5 | | |
| Noise figure | | | | | dBm | $I_C = 8\text{ mA}$ |
| <ul style="list-style-type: none"> Minimum noise figure | NF_{min} | 0.5 | 1.1 | 2.1 | | |
| Linearity | | | | | dBm | $I_C = 40\text{ mA}$, $Z_S = Z_L = 50\text{ }\Omega$, $Z_S = Z_{S,opt}$, $Z_L = Z_{L,opt}$ |
| <ul style="list-style-type: none"> 3rd order intercept point at output | OIP_3 | – | 29.5 | – | | |
| <ul style="list-style-type: none"> 1 dB gain compression point at output | OP_{1dB} OP_{1dB} | | 16 19.5 | | | |

Table 7 AC characteristics, $V_{CE} = 3\text{ V}$, $f = 3\text{ GHz}$

| Parameter | Symbol | Values | | | Unit | Note or test condition |
|---|--------------------------|------------|-----------|-------------|------|------------------------|
| | | Min. | Typ. | Max. | | |
| Power gain | | | | | dB | $I_C = 40\text{ mA}$ |
| <ul style="list-style-type: none"> Maximum power gain Transducer gain | G_{ma} $ S_{21} ^2$ | 7.5 5.5 | 10 7.5 | 12.5 9.5 | | |

Note: $G_{ms} = |S_{21} / S_{12}|$ for $k < 1$; $G_{ma} = |S_{21} / S_{12}| (k - (k^2 - 1)^{1/2})$ for $k > 1$. In order to get the NF_{min} values stated in this chapter, the test fixture losses have been subtracted from all measured results. OIP_3 value depends on termination of all intermodulation frequency components. Termination used for this measurement is 50 Ω from 0.1 MHz to 6 GHz.

Package information TSLP-3-1

4 Package information TSLP-3-1

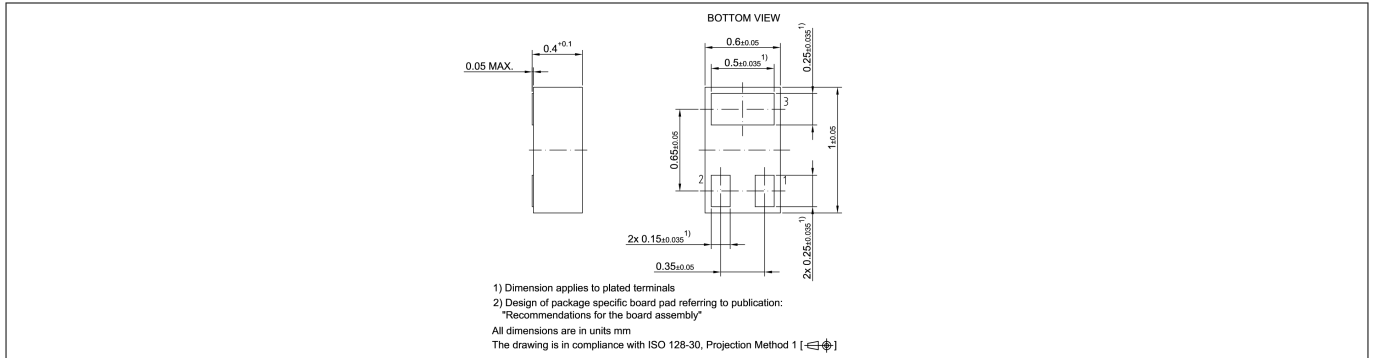


Figure 3 Package outline

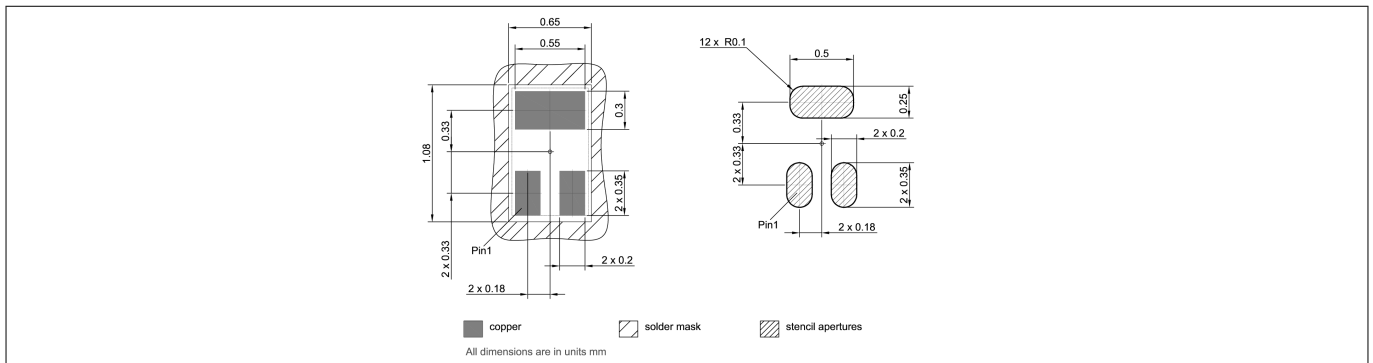


Figure 4 Foot print

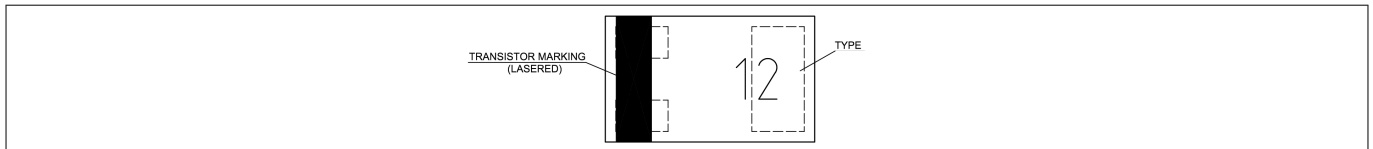


Figure 5 Marking layout example

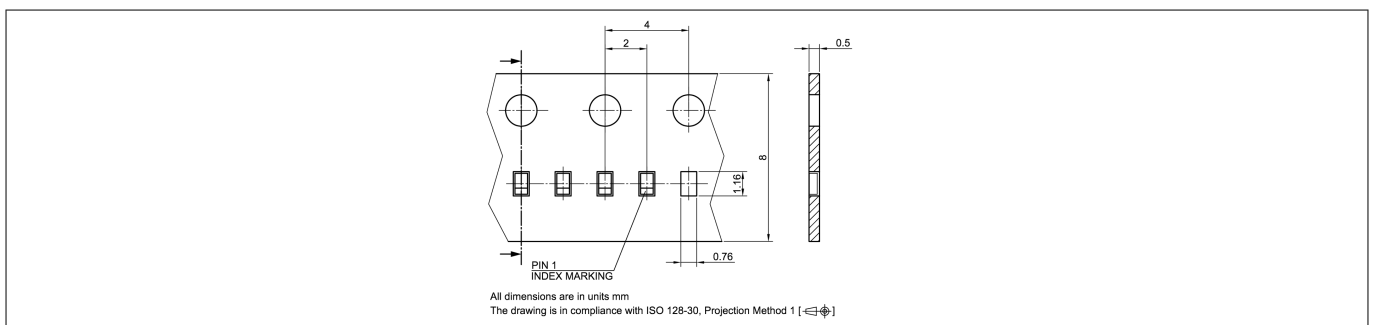


Figure 6 Tape information

Note: See our [Recommendations for Printed Circuit Board Assembly of TSLP/TSSLP/TSNP Packages](#). The marking layout is an example. For the real marking code refer to the device information on the first page. The number of characters shown in the layout example is not necessarily the real one. The marking layout can consist of less characters.

Revision history

Revision history

| Document version | Date of release | Description of changes |
|------------------|-----------------|------------------------|
| Revision 2.0 | 2019-01-25 | New datasheet layout. |